

<b>Notice of References Cited</b>	Application/Control No. 10/511,312	Applicant(s)/Patent Under Reexamination TANABE ET AL.	
	Examiner Eueng-nan Yeh	Art Unit 2624	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-5,848,192	12-1998	Smith et al.	382/232
*	C	US-6,549,663	04-2003	Yokose et al.	382/232
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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